



December 2009

## FDME1023PZT

### Dual P-Channel PowerTrench<sup>®</sup> MOSFET -20 V, -2.3 A, 142 mΩ

#### Features

- Max  $r_{DS(on)}$  = 142 mΩ at  $V_{GS} = -4.5$  V,  $I_D = -2.3$  A
- Max  $r_{DS(on)}$  = 213 mΩ at  $V_{GS} = -2.5$  V,  $I_D = -1.8$  A
- Max  $r_{DS(on)}$  = 331 mΩ at  $V_{GS} = -1.8$  V,  $I_D = -1.5$  A
- Max  $r_{DS(on)}$  = 530 mΩ at  $V_{GS} = -1.5$  V,  $I_D = -1.2$  A
- Low profile: 0.55 mm maximum in the new package MicroFET 1.6x1.6 Thin
- Free from halogenated compounds and antimony oxides
- HBM ESD protection level > 1600V (Note3)
- RoHS Compliant



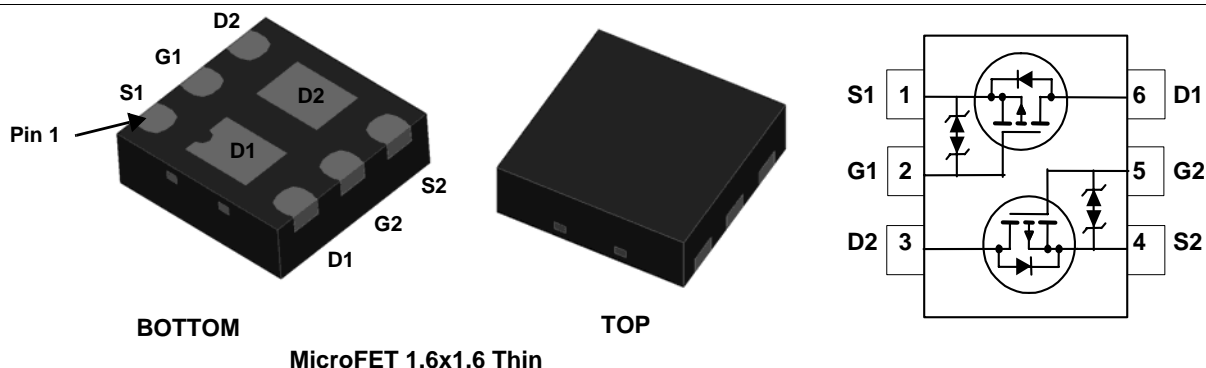
#### General Description

This device is designed specifically as a single package solution for the battery charges switch in cellular handset and other ultra-portable applications. It features two independent P-Channel MOSFETs with low on-state resistance for minimum conduction losses. When connected in the typical common source configuration, bi-directional current flow is possible.

The MicroFET 1.6x1.6 Thin package offers exceptional thermal performance for its physical size and is well suited to switching and linear mode applications.

#### Applications

- Load Switch
- Battery Charging
- Battery Disconnect Switch



#### MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain to Source Voltage	-20	V
$V_{GS}$	Gate to Source Voltage	±8	V
$I_D$	Drain Current -Continuous $T_A = 25$ °C (Note 1a)	-2.3	A
	-Pulsed	-6	
$P_D$	Power Dissipation for Single Operation $T_A = 25$ °C (Note 1a)	1.3	W
	Power Dissipation for Single Operation $T_A = 25$ °C (Note 1b)	0.6	
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	°C

#### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Single Operation) (Note 1a)	95	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Single Operation) (Note 1b)	210	

#### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
2T	FDME1023PZT	MicroFET 1.6x1.6 Thin	7"	8 mm	5000 units

**Electrical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
--------	-----------	-----------------	-----	-----	-----	-------

**Off Characteristics**

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = -250\ \mu\text{A}$ , $V_{GS} = 0\ \text{V}$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		-12		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -16\ \text{V}$ , $V_{GS} = 0\ \text{V}$			-1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 8\ \text{V}$ , $V_{DS} = 0\ \text{V}$			$\pm 10$	$\mu\text{A}$

**On Characteristics**

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = -250\ \mu\text{A}$	-0.4	-0.6	-1.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		2		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Drain to Source On Resistance	$V_{GS} = -4.5\ \text{V}$ , $I_D = -2.3\ \text{A}$		95	142	m $\Omega$
		$V_{GS} = -2.5\ \text{V}$ , $I_D = -1.8\ \text{A}$		120	213	
		$V_{GS} = -1.8\ \text{V}$ , $I_D = -1.5\ \text{A}$		150	331	
		$V_{GS} = -1.5\ \text{V}$ , $I_D = -1.2\ \text{A}$		190	530	
		$V_{GS} = -4.5\ \text{V}$ , $I_D = -2.3\ \text{A}$ , $T_J = 125\text{ }^\circ\text{C}$		128	190	
$g_{FS}$	Forward Transconductance	$V_{DS} = -4.5\ \text{V}$ , $I_D = -2.3\ \text{A}$		7		S

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	$V_{DS} = -10\ \text{V}$ , $V_{GS} = 0\ \text{V}$ , $f = 1\ \text{MHz}$		305	405	pF
$C_{oss}$	Output Capacitance			55	75	pF
$C_{rss}$	Reverse Transfer Capacitance			50	75	pF

**Switching Characteristics**

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -10\ \text{V}$ , $I_D = -1\ \text{A}$ $V_{GS} = -4.5\ \text{V}$ , $R_{GEN} = 6\ \Omega$		4.7	10	ns
$t_r$	Rise Time			4.8	10	ns
$t_{d(off)}$	Turn-Off Delay Time			33	53	ns
$t_f$	Fall Time			16	29	ns
$Q_g$	Total Gate Charge		$V_{DD} = -10\ \text{V}$ , $I_D = -2.3\ \text{A}$ $V_{GS} = -4.5\ \text{V}$		5.5	7.7
$Q_{gs}$	Gate to Source Gate Charge			0.6		nC
$Q_{gd}$	Gate to Drain "Miller" Charge			1.4		nC

**Drain-Source Diode Characteristics**

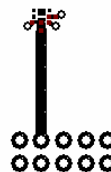
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\ \text{V}$ , $I_S = -0.9\ \text{A}$ (Note 2)		-0.8	-1.2	V
$t_{rr}$	Reverse Recovery Time	$I_F = -2.3\ \text{A}$ , $di/dt = 100\ \text{A}/\mu\text{s}$		16	29	ns
$Q_{rr}$	Reverse Recovery Charge			4.4	10	nC

**Notes:**

1.  $R_{\theta JA}$  is determined with the device mounted on a  $1\ \text{in}^2$  pad 2 oz copper pad on a  $1.5 \times 1.5\ \text{in.}$  board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $95\text{ }^\circ\text{C}/\text{W}$  when mounted on a  $1\ \text{in}^2$  pad of 2 oz copper.



b.  $210\text{ }^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width <  $300\ \mu\text{s}$ , Duty cycle < 2.0%.

3. The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

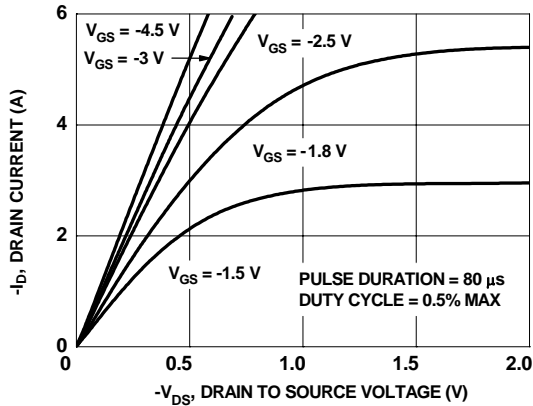


Figure 1. On Region Characteristics

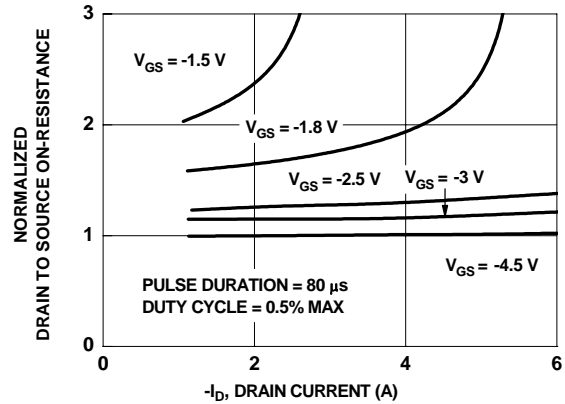


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

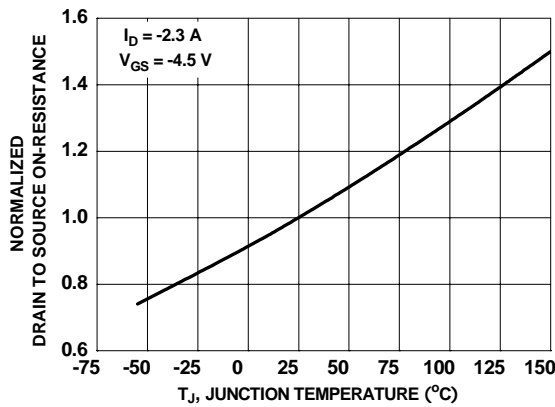


Figure 3. Normalized On Resistance vs Junction Temperature

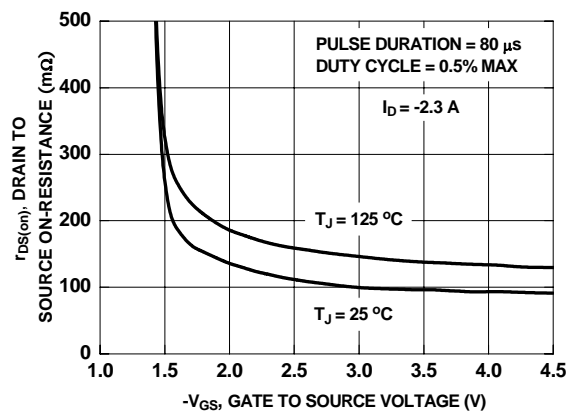


Figure 4. On-Resistance vs Gate to Source Voltage

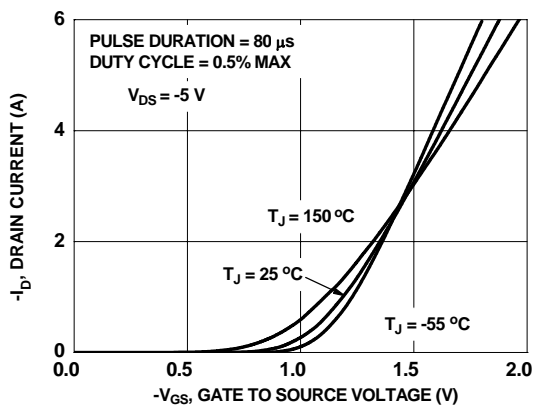


Figure 5. Transfer Characteristics

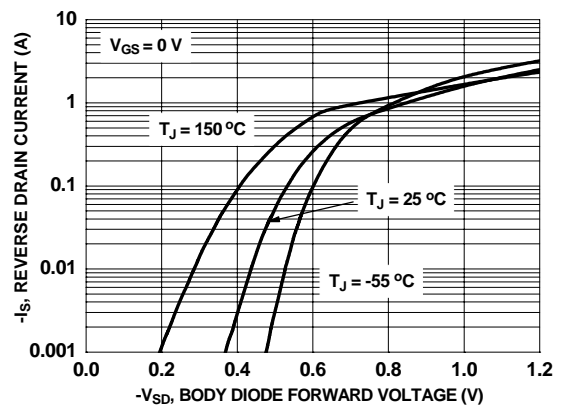
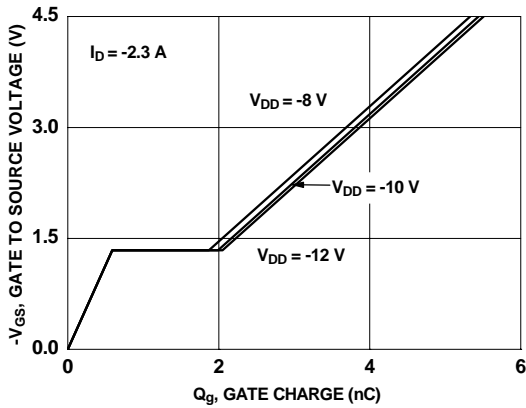
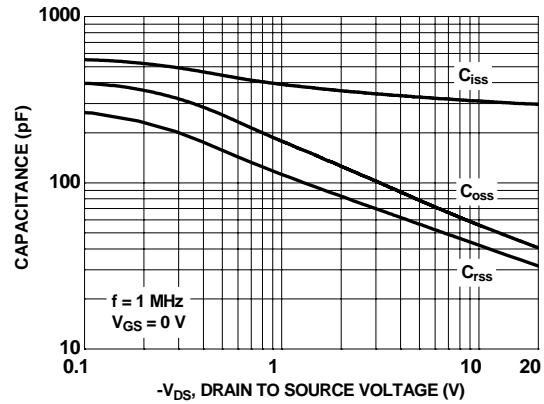


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

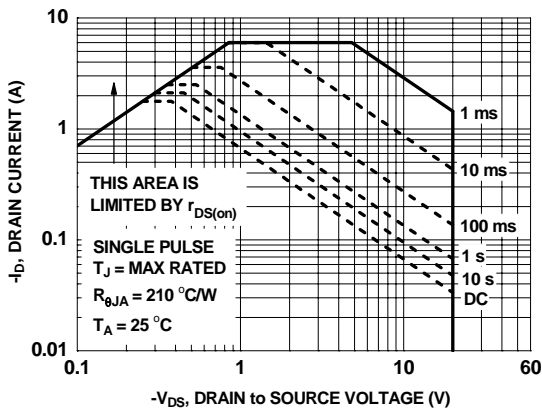
**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted



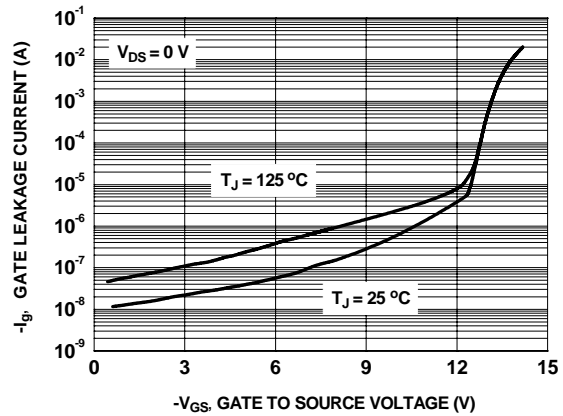
**Figure 7. Gate Charge Characteristics**



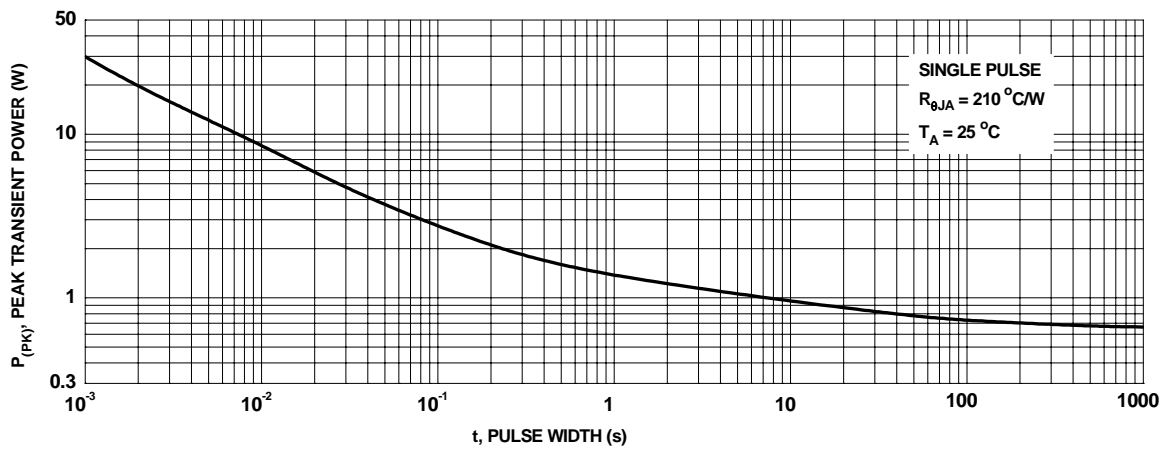
**Figure 8. Capacitance vs Drain to Source Voltage**



**Figure 9. Forward Bias Safe Operating Area**

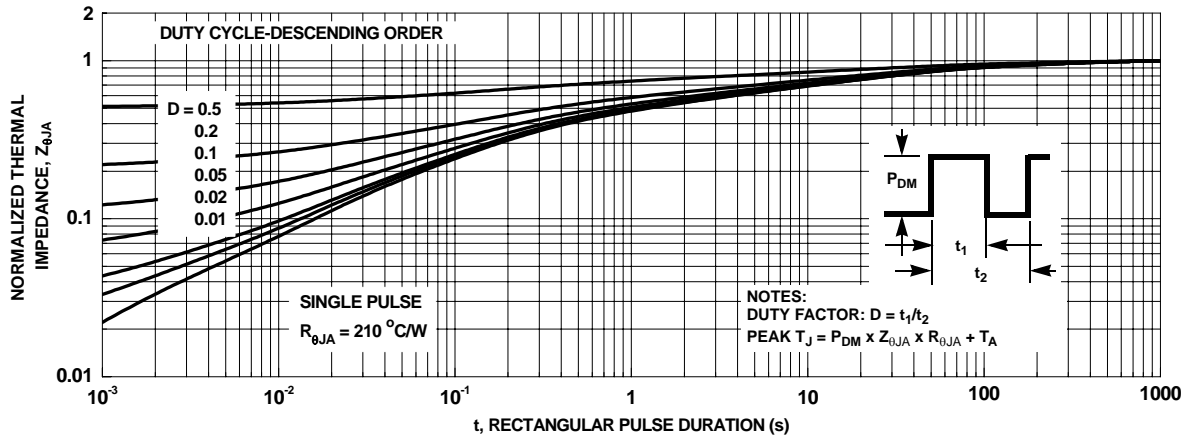


**Figure 10. Gate Leakage Current vs Gate to Source Voltage**



**Figure 11. Single Pulse Maximum Power Dissipation**

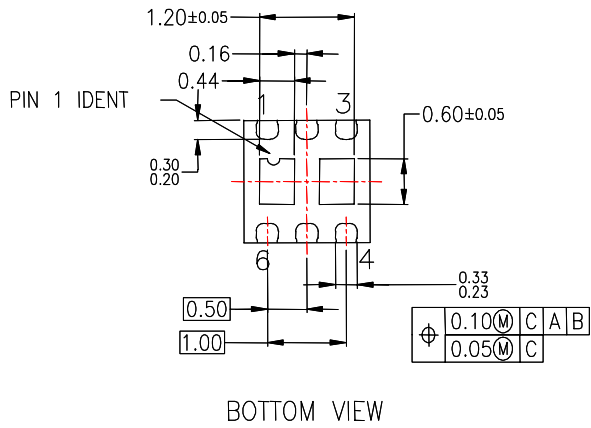
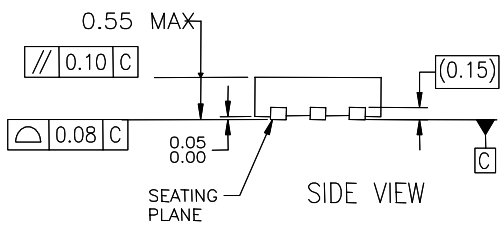
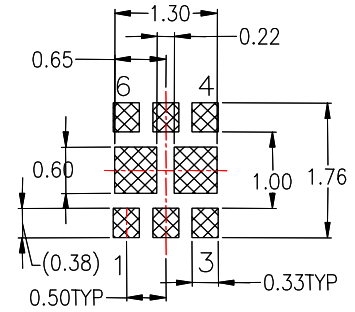
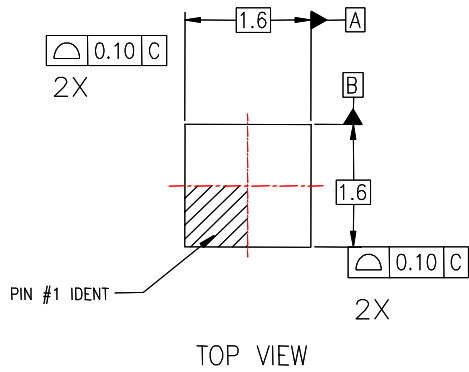
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



**Figure 12. Junction-to-Ambient Transient Thermal Response Curve**

FDME1023PZT Dual P-Channel PowerTrench<sup>®</sup> MOSFET

### Dimensional Outline and Pad Layout



FDME1023PZT Dual P-Channel PowerTrench<sup>®</sup> MOSFET



**TRADEMARKS**

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

- |                          |                         |  |   |                  |
|--------------------------|-------------------------|--|---|------------------|
| AccuPower™               | FlashWriter®*           | Power-SPM™                                   | <p>SYSTEM GENERAL®<br/>The Power Franchise®</p> <p>the power®<br/>franchise</p> <p>TinyBoost™</p> |                  |
| Auto-SPM™                | FPS™                    | PowerTrench®                                 |   | TinyBuck™        |
| Build it Now™            | F-PFST™                 | PowerXS™                                     |   | TinyCalc™        |
| CorePLUS™                | FRFET®                  | Programmable Active Droop™                   |   | TinyLogic®       |
| CorePOWER™               | Global Power ResourceSM | QFET®  |   | TINYOPTO™        |
| CROSSVOLT™               | Green FPS™              | QS™  |   | TinyPower™       |
| CTL™                     | Green FPS™ e-Series™    | Quiet Series™                                |   | TinyPWM™         |
| Current Transfer Logic™  | Gmax™                   | RapidConfigure™                              |   | TinyWire™        |
| DEUXPEED®                | GTO™                    | <p>Saving our world, 1mW/W/kW at a time™</p> |   | TriFault Detect™ |
| EcoSPARK®                | IntelliMAX™             |  |   | SMART START™     |
| EfficientMax™            | ISOPLANAR™              | SMART MAX™                                   | μSerDes™  |                  |
| EZSWITCH™*               | MegaBuck™               | SPM®   | <p>SerDes®</p> <p>UHC®</p>  |                  |
| <p>Fairchild®</p>        | MICROCOUPLER™           | STEALTH™                                     |   | Ultra FRFET™     |
|                          | MicroFET™               | SuperFET™                                    |   | UniFET™          |
| Fairchild Semiconductor® | MicroPak™               | SuperSOT™-3                                  |   | VCX™             |
| FACT Quiet Series™       | MillerDrive™            | SuperSOT™-6                                  |   | VisualMax™       |
| FACT®                    | MotionMax™              | SuperSOT™-8                                  |   | XS™              |
| FAST®                    | Motion-SPM™             | SupreMOS™                                    |   |                  |
| FastvCore™               | OPTOLOGIC®              | SyncFET™                                     |   |                  |
| FETBench™                | OPTOPLANAR®             | Sync-Lock™                                   |   |                  |
|                          | <p>PDP SPM™</p>         |  |   |                  |
|                          |                         |  |   |                  |

\*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

**DISCLAIMER**

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

**LIFE SUPPORT POLICY**

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

**ANTI-COUNTERFEITING POLICY**

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

**PRODUCT STATUS DEFINITIONS**

**Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. I44